Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/660,460	OLDHAM ET AL.	
Examiner	Art Unit	
Patrick J. Lee	2878	

SEARCHED					
Class	Subclass	Date	Examiner		
250	208.1, 234-236, 573	11/30/05	PL		
382	145, 149	[PL		
356	237.4		PL		
356	237.5	V	PL		
·					

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Consulted w/ S. Allen AU 2878 CL 250	11/28/2005	PL		
East (see attached) - USPAT, US- PGPUB, EPO, JPO, DERWENT	11/28/2005	PL		
East (see attached) - USPAT, US- PGPUB, EPO, JPO, DERWENT	11/30/2005	PL		